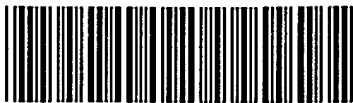


Search Notes



Application/Control No.

10/693,140

Examiner

Emmanuel Bayard

Applicant(s)/Patent under Reexamination

WANG ET AL.

Art Unit

2611

SEARCHED

Class	Subclass	Date	Examiner
375	259	7/5/06	EL
↑	260	↑	↑
	295	↓	↓
375	292	7/5/06	EL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
375	295	7/5/06	EL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EL AS	7/5/06	EL